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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/661,052	EROL ET AL.	
Examiner	Art Unit	
Dennis Myint	2162	

SEARCHED				
Class	Subclass	Date	Examiner	
715	500.1	3/7/2006	DM	
704	3	3/7/2006	DM	
707	-1	11/14/2006	DM	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (EPO; JPO; IBM; USPAT)	3/7/2006	DM		
EAST (EPO; JPO; IBM; USPAT)	3/7/2006	, DM		
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